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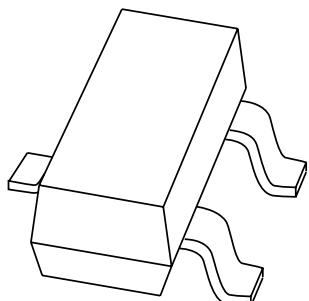
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Kind regards,

Team Nexperia

DATA SHEET



BSH103 N-channel enhancement mode MOS transistor

Product specification

1998 Feb 11

Supersedes data of 1998 Jan 30

File under Discrete Semiconductors, SC13b

N-channel enhancement mode MOS transistor

BSH103

FEATURES

- Very low threshold
- High-speed switching
- No secondary breakdown
- Direct interface to C-MOS, TTL etc.

PINNING - SOT23

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | g | gate |
| 2 | s | source |
| 3 | d | drain |

APPLICATIONS

- Power management
- DC to DC converters
- Battery powered applications
- 'Glue-logic'; interface between logic blocks and/or periphery
- General purpose switch.

DESCRIPTION

N-channel enhancement mode MOS transistor in a SOT23 SMD package.

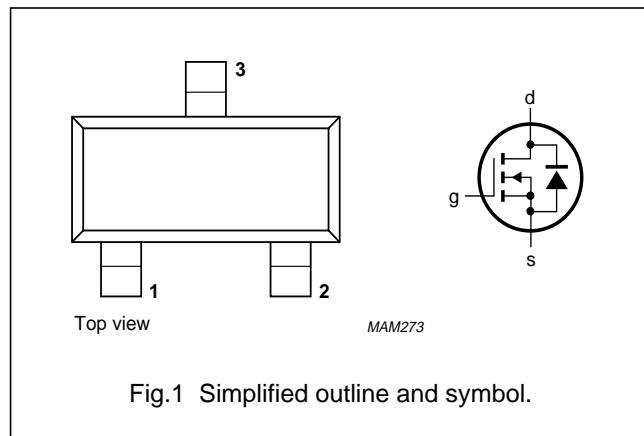


Fig.1 Simplified outline and symbol.

QUICK REFERENCE DATA

| SYMBOL | PARAMETERS | CONDITIONS | MIN. | MAX. | UNIT |
|------------|------------------------------------|--|------|---------|----------|
| V_{DS} | drain-source voltage (DC) | | – | 30 | V |
| V_{SD} | source-drain diode forward voltage | $V_{GD} = 0$; $I_S = 0.5 \text{ A}$ | – | 1 | V |
| V_{GS} | gate-source voltage (DC) | | – | ± 8 | V |
| V_{GSTh} | gate-source threshold voltage | $V_{DS} = V_{GS}$; $I_D = 1 \text{ mA}$ | 0.4 | – | V |
| I_D | drain current (DC) | $T_s = 80^\circ\text{C}$ | – | 0.85 | A |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 2.5 \text{ V}$; $I_D = 0.5 \text{ A}$ | – | 0.5 | Ω |
| P_{tot} | total power dissipation | $T_s = 80^\circ\text{C}$ | – | 0.5 | W |

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

N-channel enhancement mode MOS transistor

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

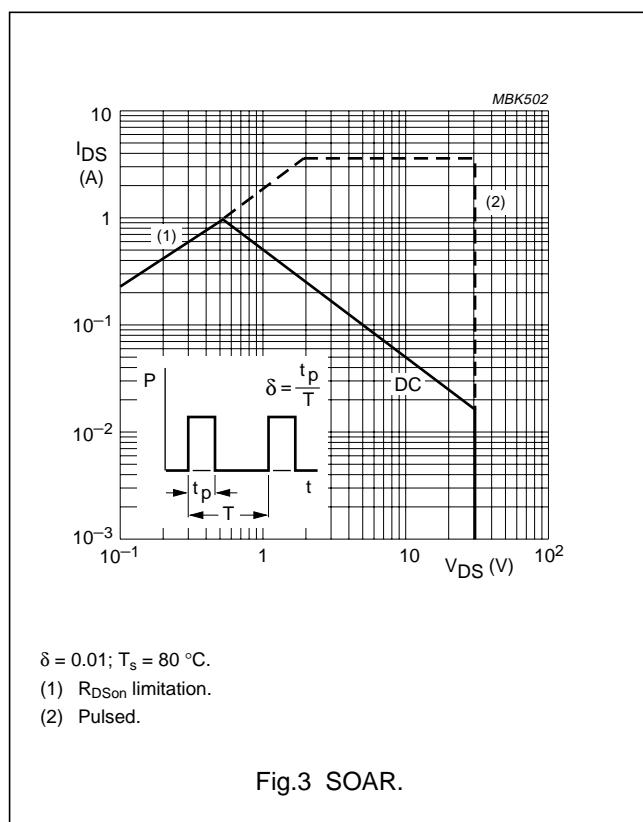
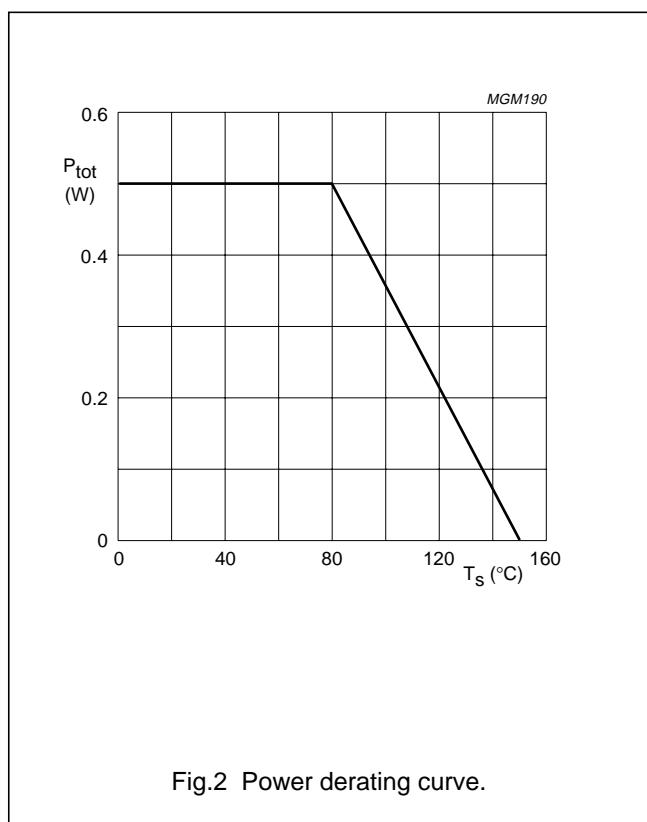
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|--------------------------------|--|------|---------|------------------|
| V_{DS} | drain-source voltage (DC) | | – | 30 | V |
| V_{GS} | gate-source voltage (DC) | | – | ± 8 | V |
| I_D | drain current (DC) | $T_s = 80^\circ\text{C}$; note 1 | – | 0.85 | A |
| I_{DM} | peak drain current | note 2 | – | 3.4 | A |
| P_{tot} | total power dissipation | $T_s = 80^\circ\text{C}$ | – | 0.5 | W |
| | | $T_{\text{amb}} = 25^\circ\text{C}$; note 3 | – | 0.75 | W |
| | | $T_{\text{amb}} = 25^\circ\text{C}$; note 4 | – | 0.54 | W |
| T_{stg} | storage temperature | | -55 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | -55 | +150 | $^\circ\text{C}$ |

Source-drain diode

| | | | | | |
|----------|----------------------------|--------------------------|---|-----|---|
| I_S | source current (DC) | $T_s = 80^\circ\text{C}$ | – | 0.5 | A |
| I_{SM} | peak pulsed source current | note 2 | – | 2 | A |

Notes

1. T_s is the temperature at the soldering point of the drain lead.
2. Pulse width and duty cycle limited by maximum junction temperature.
3. Device mounted on printed-circuit board with an $R_{\text{th}\ a\text{-tp}}$ (ambient to tie-point) of 27.5 K/W.
4. Device mounted on printed-circuit board with an $R_{\text{th}\ a\text{-tp}}$ (ambient to tie-point) of 90 K/W.



N-channel enhancement mode MOS transistor

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THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 140 | K/W |

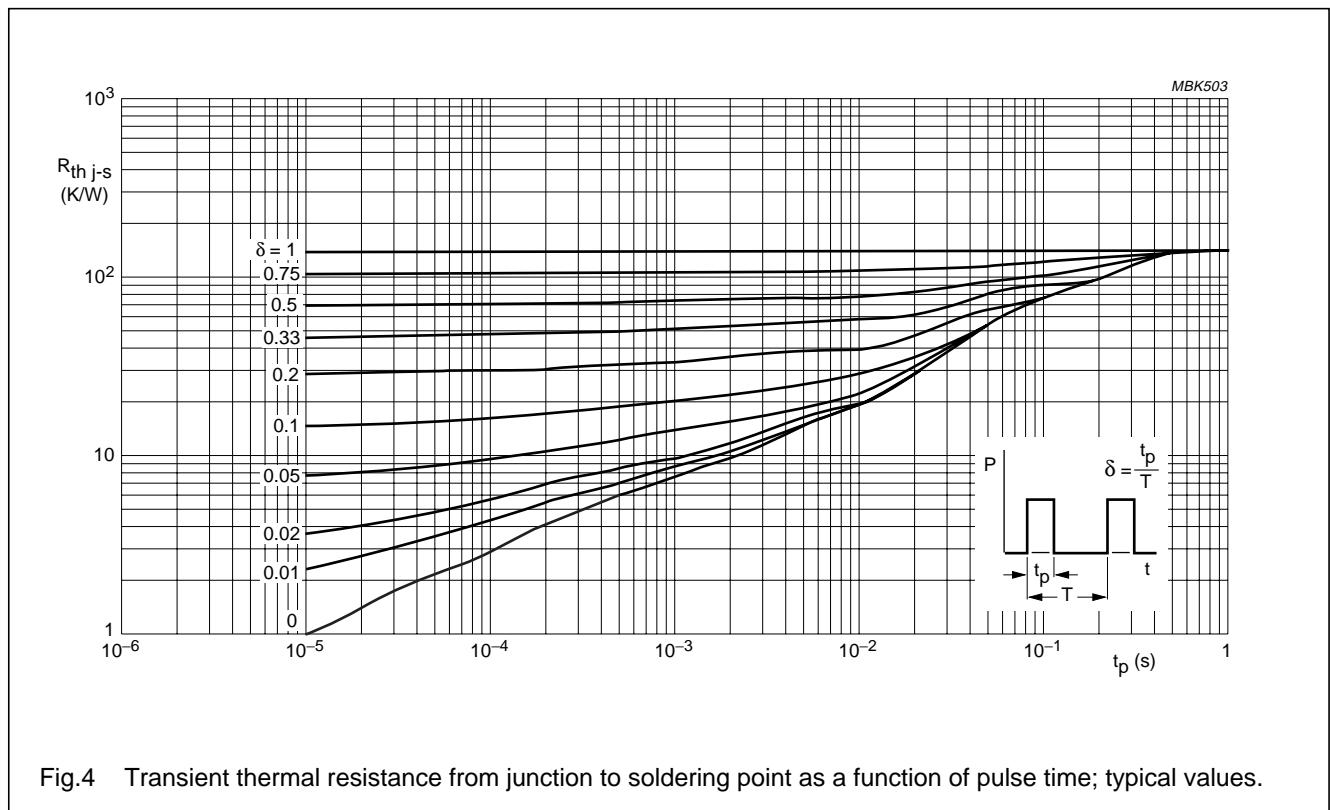


Fig.4 Transient thermal resistance from junction to soldering point as a function of pulse time; typical values.

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CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------------------------|----------------------------------|---|------|------|-----------|----------|
| $V_{(\text{BR})\text{DSS}}$ | drain-source breakdown voltage | $V_{GS} = 0$; $I_D = 10 \mu\text{A}$ | 30 | — | — | V |
| $V_{GS\text{th}}$ | gate-source threshold voltage | $V_{GS} = V_{DS}$; $I_D = 1 \text{ mA}$ | 0.4 | — | — | V |
| I_{DSS} | drain-source leakage current | $V_{GS} = 0$; $V_{DS} = 24 \text{ V}$ | — | — | 100 | nA |
| I_{GSS} | gate leakage current | $V_{GS} = \pm 8 \text{ V}$; $V_{DS} = 0$ | — | — | ± 100 | nA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 4.5 \text{ V}$; $I_D = 0.5 \text{ A}$ | — | — | 0.4 | Ω |
| | | $V_{GS} = 2.5 \text{ V}$; $I_D = 0.5 \text{ A}$ | — | — | 0.5 | Ω |
| | | $V_{GS} = 1.8 \text{ V}$; $I_D = 0.25 \text{ A}$ | — | — | 0.6 | Ω |
| C_{iss} | input capacitance | $V_{GS} = 0$; $V_{DS} = 24 \text{ V}$; $f = 1 \text{ MHz}$ | — | 83 | — | pF |
| C_{oss} | output capacitance | $V_{GS} = 0$; $V_{DS} = 24 \text{ V}$; $f = 1 \text{ MHz}$ | — | 27 | — | pF |
| C_{rss} | reverse transfer capacitance | $V_{GS} = 0$; $V_{DS} = 24 \text{ V}$; $f = 1 \text{ MHz}$ | — | 14 | — | pF |
| Q_G | total gate charge | $V_{GS} = 4.5 \text{ V}$; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $T_{\text{amb}} = 25^\circ\text{C}$ | — | 2100 | — | pC |
| Q_{GS} | gate-source charge | $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $T_{\text{amb}} = 25^\circ\text{C}$ | — | 95 | — | pC |
| Q_{GD} | gate-drain charge | $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $T_{\text{amb}} = 25^\circ\text{C}$ | — | 670 | — | pC |

Switching times

| | | | | | | |
|---------------------|-------------------------|--|---|-----|---|----|
| $t_{d(\text{on})}$ | turn-on delay time | $V_{GS} = 0$ to 8 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 2.5 | — | ns |
| t_f | fall time | $V_{GS} = 0$ to 8 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 3.5 | — | ns |
| t_{on} | turn-on switching time | $V_{GS} = 0$ to 8 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 6 | — | ns |
| $t_{d(\text{off})}$ | turn-off delay time | $V_{GS} = 8$ to 0 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 20 | — | ns |
| t_r | rise time | $V_{GS} = 8$ to 0 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 7 | — | ns |
| t_{off} | turn-off switching time | $V_{GS} = 8$ to 0 V ; $V_{DD} = 15 \text{ V}$; $I_D = 0.5 \text{ A}$; $R_{\text{gen}} = 6 \Omega$ | — | 27 | — | ns |

Source-drain diode

| | | | | | | |
|----------|------------------------------------|--|---|----|---|----|
| V_{SD} | source-drain diode forward voltage | $V_{GD} = 0$; $I_S = 0.5 \text{ A}$ | — | — | 1 | V |
| t_{rr} | reverse recovery time | $I_S = 0.5 \text{ A}$; $di/dt = -100 \text{ A}/\mu\text{s}$ | — | 25 | — | ns |

N-channel enhancement mode MOS transistor

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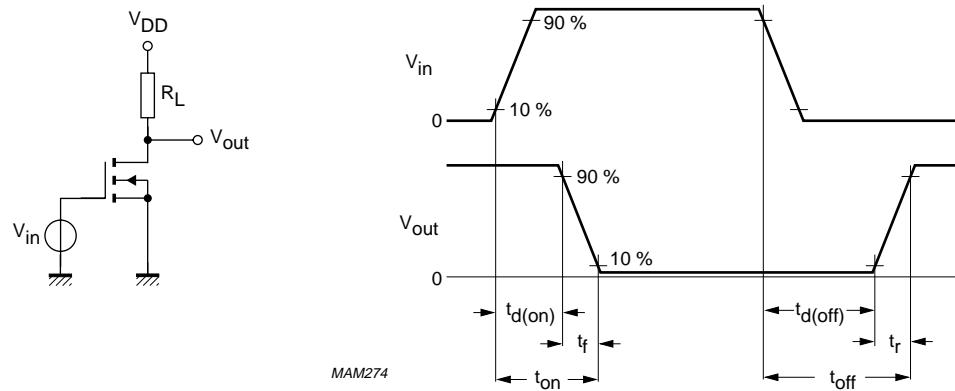
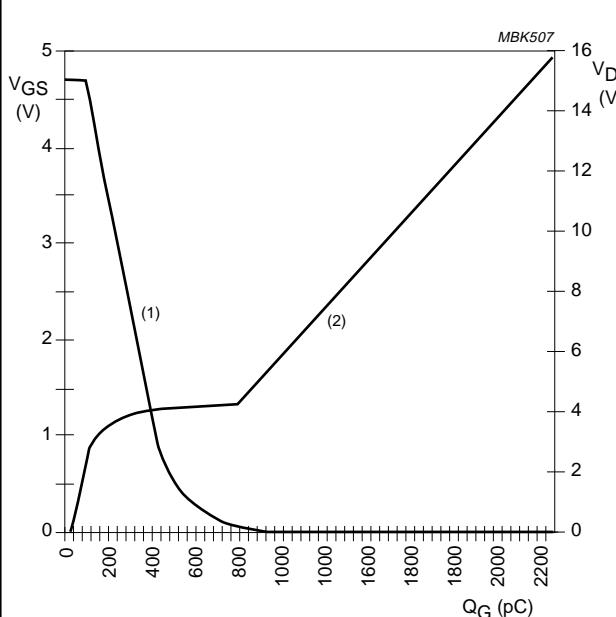
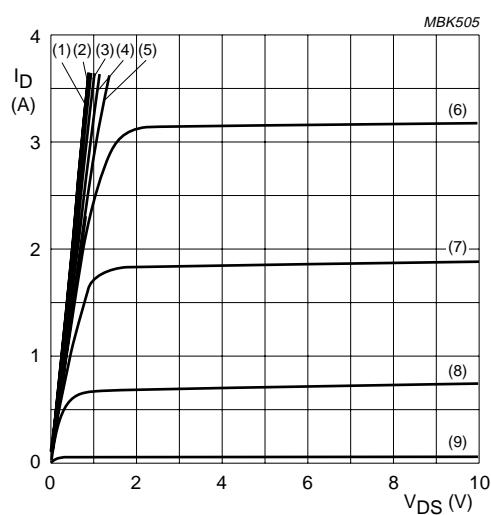


Fig.5 Switching times test circuit with input and output waveforms.

 $V_{DD} = 15 \text{ V}; I_D = 0.5 \text{ A}; T_{amb} = 25^\circ\text{C}$.

- (1) V_{DS} .
- (2) V_{GS} .

Fig.6 Gate-source and drain-source voltages as functions of total gate charge; typical values.

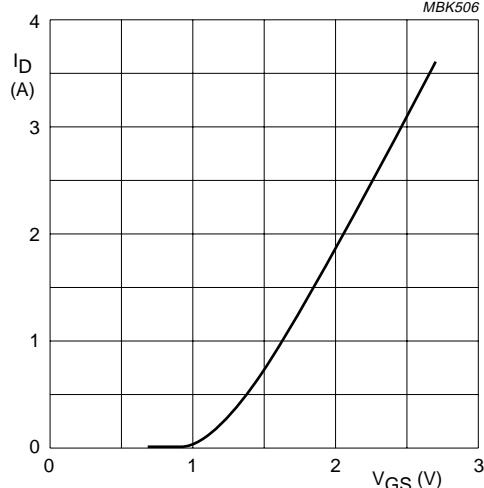
 $T_{amb} = 25^\circ\text{C}; t_p = 300 \mu\text{s}; \delta = 0$.

- | | |
|--------------------------------|--------------------------------|
| (1) $V_{GS} = 7.5 \text{ V}$. | (5) $V_{GS} = 3 \text{ V}$. |
| (2) $V_{GS} = 5.5 \text{ V}$. | (6) $V_{GS} = 2.5 \text{ V}$. |
| (3) $V_{GS} = 4.5 \text{ V}$. | (7) $V_{GS} = 2 \text{ V}$. |
| (4) $V_{GS} = 3.5 \text{ V}$. | (8) $V_{GS} = 1.5 \text{ V}$. |
| | (9) $V_{GS} = 1 \text{ V}$. |

Fig.7 Output characteristics; typical values.

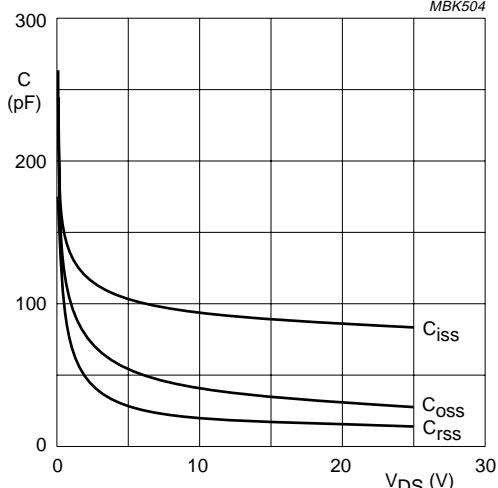
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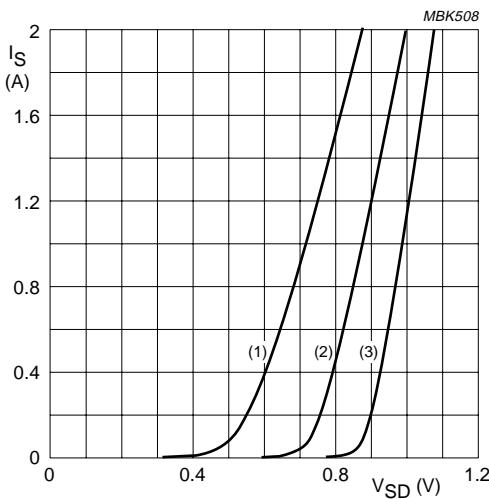
$V_{DS} = 10$ V; $T_{amb} = 25$ °C; $t_p = 300$ µs; $\delta = 0$.

Fig.8 Transfer characteristic; typical values.



$V_{GS} = 0$; $f = 1$ MHz; $T_{amb} = 25$ °C.

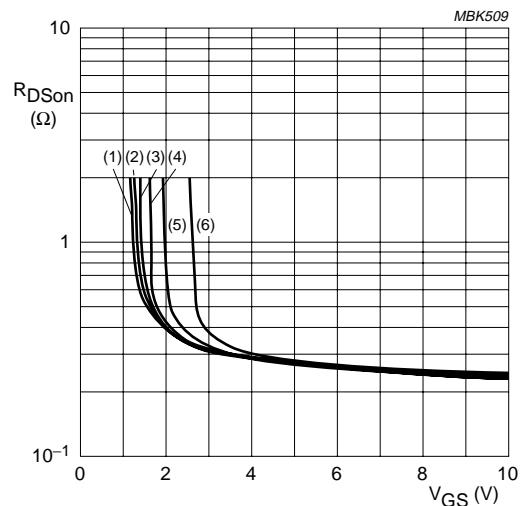
Fig.9 Capacitance as a function of drain-source voltage; typical values.



$V_{GD} = 0$.

- (1) $T_{amb} = 150$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = -65$ °C.

Fig.10 Source current as a function of source-drain diode forward voltage; typical values.



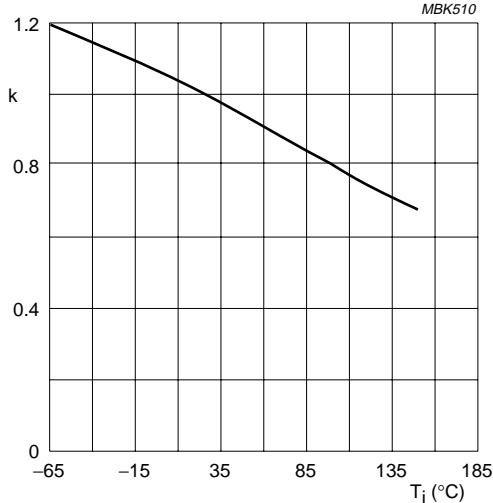
$T_{amb} = 25$ °C; $t_p = 300$ µs; $\delta = 0$.

- | | |
|---------------------|--------------------|
| (1) $I_D = 0.1$ A. | (4) $I_D = 0.9$ A. |
| (2) $I_D = 0.22$ A. | (5) $I_D = 1.8$ A. |
| (3) $I_D = 0.45$ A. | (6) $I_D = 3.6$ A. |

Fig.11 Drain-source on-state resistance as a function of gate-source voltage; typical values.

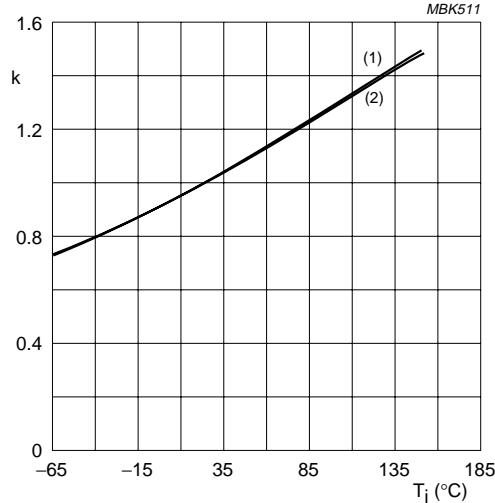
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$$k = \frac{V_{GS\text{th}} \text{ at } T_j}{V_{GS\text{th}} \text{ at } 25^\circ\text{C}} . \quad V_{GS\text{th}} \text{ at } V_{DS} = V_{GS}; I_D = 1 \text{ mA.}$$

Fig.12 Temperature coefficient of gate-source threshold voltage as a function of junction temperature; typical values.



$$k = \frac{R_{DS\text{on}} \text{ at } T_j}{R_{DS\text{on}} \text{ at } 25^\circ\text{C}} . \quad \begin{aligned} (1) \quad & R_{DS\text{on}} \text{ at } V_{GS} = 4.5 \text{ V; } I_D = 0.5 \text{ mA.} \\ (2) \quad & R_{DS\text{on}} \text{ at } V_{GS} = 2.5 \text{ V; } I_D = 0.5 \text{ mA.} \end{aligned}$$

Fig.13 Temperature coefficient of drain-source on-resistance as a function of junction temperature; typical values.

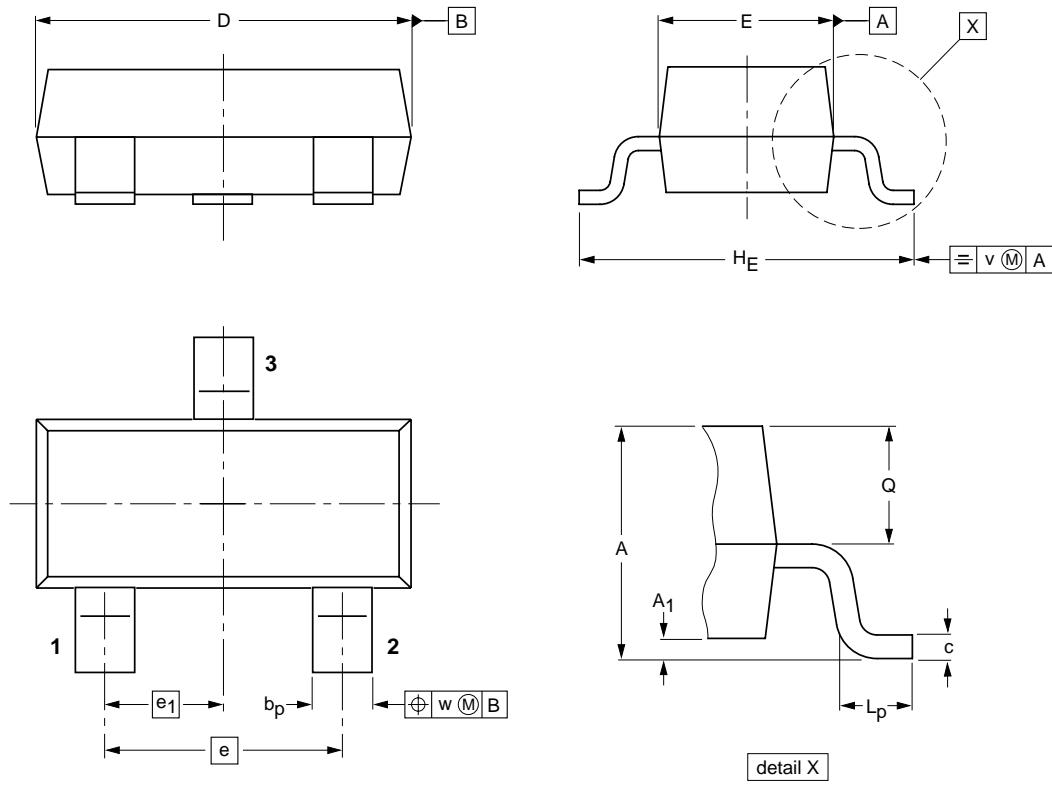
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PACKAGE OUTLINE

Plastic surface mounted package; 3 leads

SOT23

**DIMENSIONS (mm are the original dimensions)**

| UNIT | A | A_1 max. | b_p | c | D | E | e | e_1 | H_E | L_p | Q | v | w |
|------|------------|---------------|--------------|--------------|------------|------------|-----|-------|------------|--------------|--------------|-----|-----|
| mm | 1.1 0.9 | 0.1 | 0.48 0.38 | 0.15 0.09 | 3.0 2.8 | 1.4 1.2 | 1.9 | 0.95 | 2.5 2.1 | 0.45 0.15 | 0.55 0.45 | 0.2 | 0.1 |

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|------|--|------------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT23 | | | | | | 97-02-28 |

**N-channel enhancement mode
MOS transistor****BSH103****DEFINITIONS**

| Data Sheet Status | |
|---|---|
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
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